

**Search Notes**

Application/Control No.

10/809,725

Examiner

Rene Towa

Applicant(s)/Patent under  
Reexamination

CHAN, FRANK A.

Art Unit

3736

**SEARCHED**

Class	Subclass	Date	Examiner
600	573	2/1/2007	RTT
600	576	2/1/2007	RTT
600	583	2/1/2007	RTT
606	181	2/1/2007	RTT
606	182	2/1/2007	RTT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
PGPUBs	Text	2/1/2007	RTT

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
SEE SEARCH HISTORY	2/1/2007	RTT